

CAEN

Tools for Discovery



Electronic Instrumentation

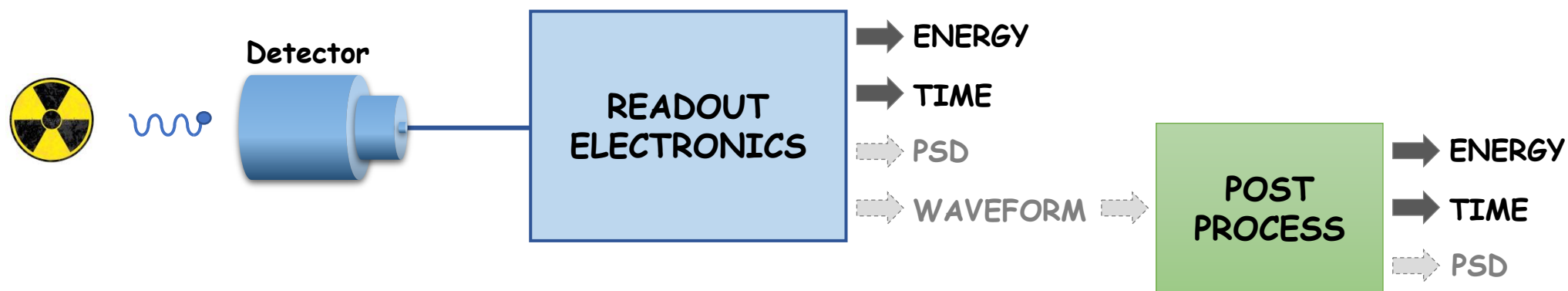
Readout chains for Fast Detectors

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Workshop on Superconducting Electronics and Detectors
JLAB, November 29th, 2022

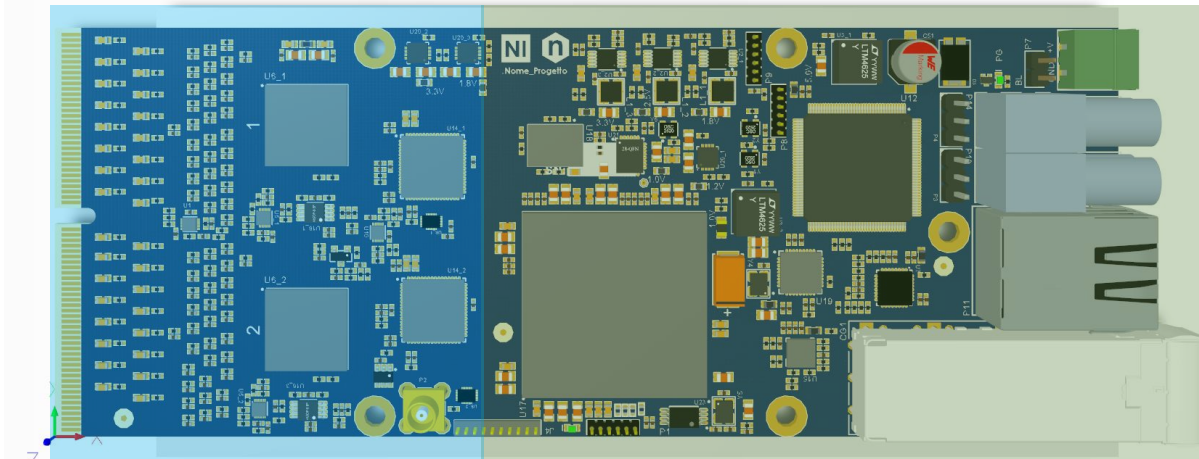
Detector Readout:

- In most cases, physics experiments require Energy (= charge or amplitude) and Timing, sometimes Pulse Shape
- Analog electronics (including many ASIC chips) provide a direct measurement of Energy and Time, converted to digital by a (slow) ADC
- Waveform digitizers acquire series of raw samples that must be post-processed (either on-line in FPGA or off-line in the software) to extract Energy and Time. Fast detectors => fast ADC (GS/s)



Readout chains

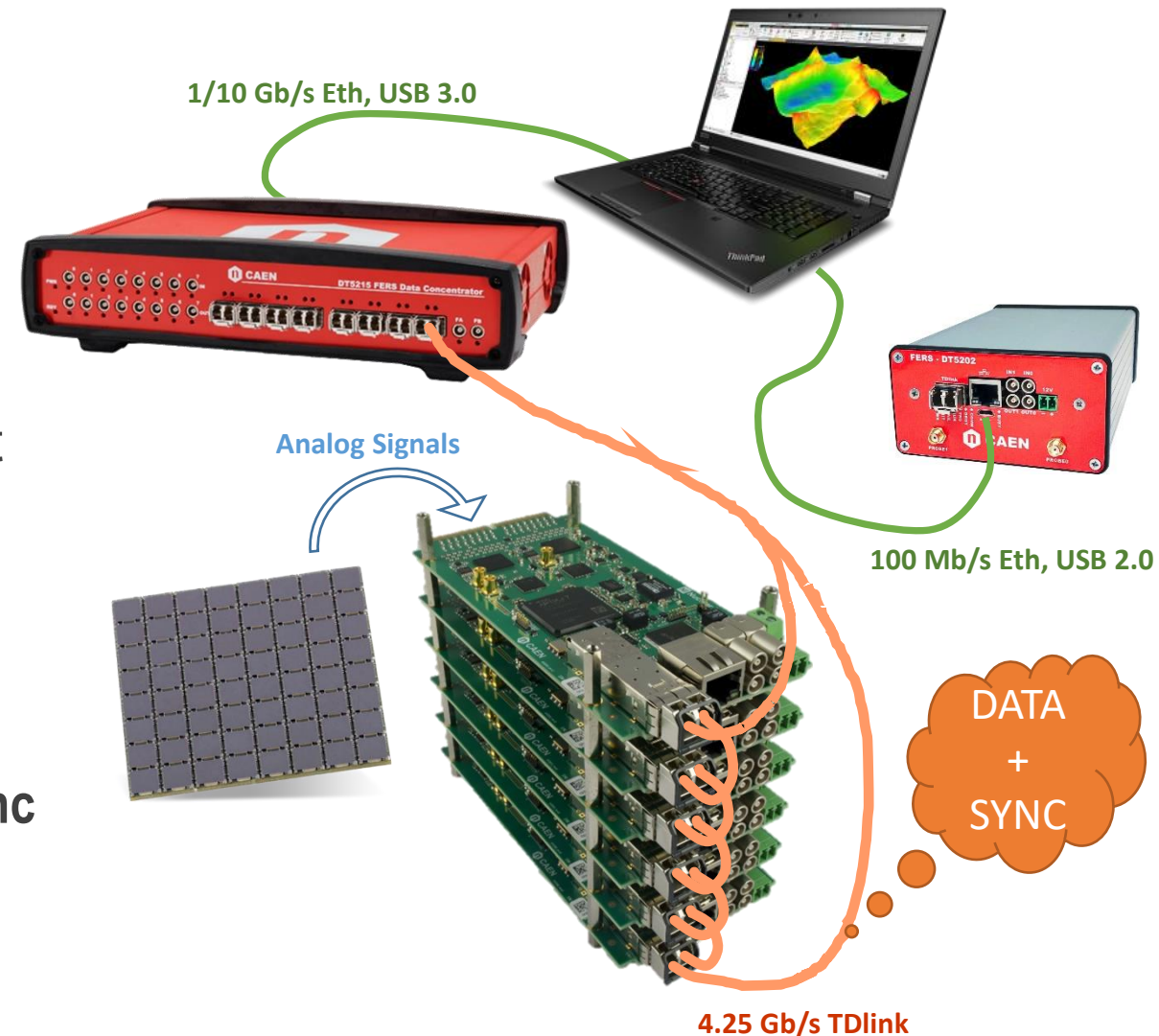
	E-Res	T-Res	Cost	Flex	Rate	Notes
<p>Detector → PA → Spect Amp / Timing Filter → Peak Sensing / CFD → ADC / TDC → ENERGY / TIME</p>	😊	😊	😞	😞	😞	<ul style="list-style-type: none"> • Power hungry • Bulky • Typ. high dead time • Old Stuff!
<p>Detector → PA → Wave Digitizer + Pulse Processing → ENERGY, TIME, Waveforms (optional)</p>	😊	😞	😞	😊	😊	<ul style="list-style-type: none"> • DPP algorithm tailored to application (FW upgrade) • fast detectors => high sampling rate => high cost • Wave interpolation • Analog Shaping ???
<p>Detector → PA → Fast Discr → picoTDC → ENERGY (ToT), TIME</p>	😞	😊	😊	😞	😊	<ul style="list-style-type: none"> • Need fast discriminators • Walk correction by ToT • Energy calculation by ToT • Pulse shape dependent => algorithm training
<p>Detector → ASIC → ENERGY, TIME</p>	😊	😊	😊	😞	😊 / 😞	<ul style="list-style-type: none"> • Low power, small size • Mounted close to detectors • Low cost but... • Need custom infrastructure • May need ext. ADC/TDC • Specific ASIC => no flexibility



DETECTOR SPECIFIC

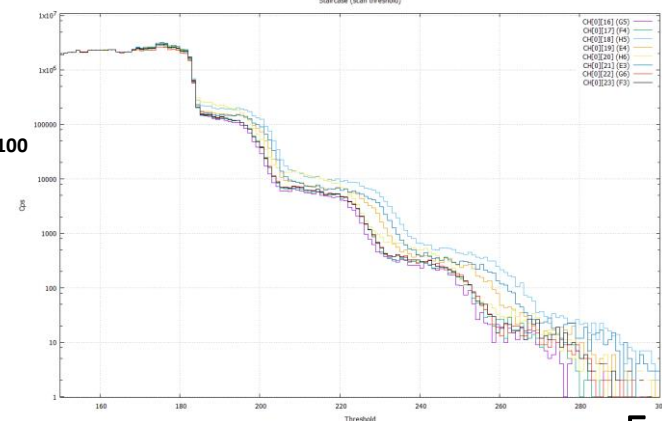
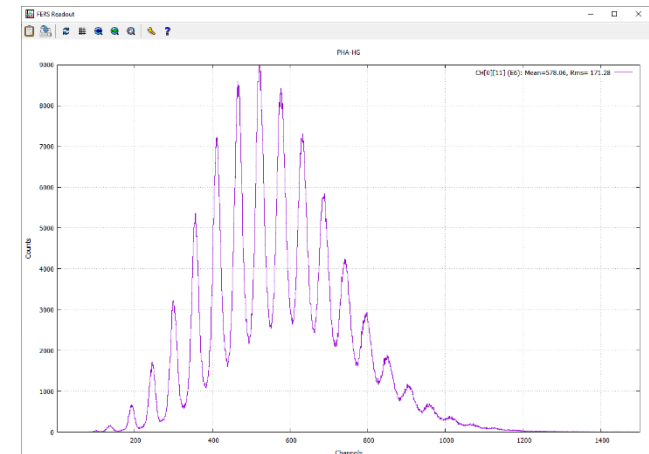
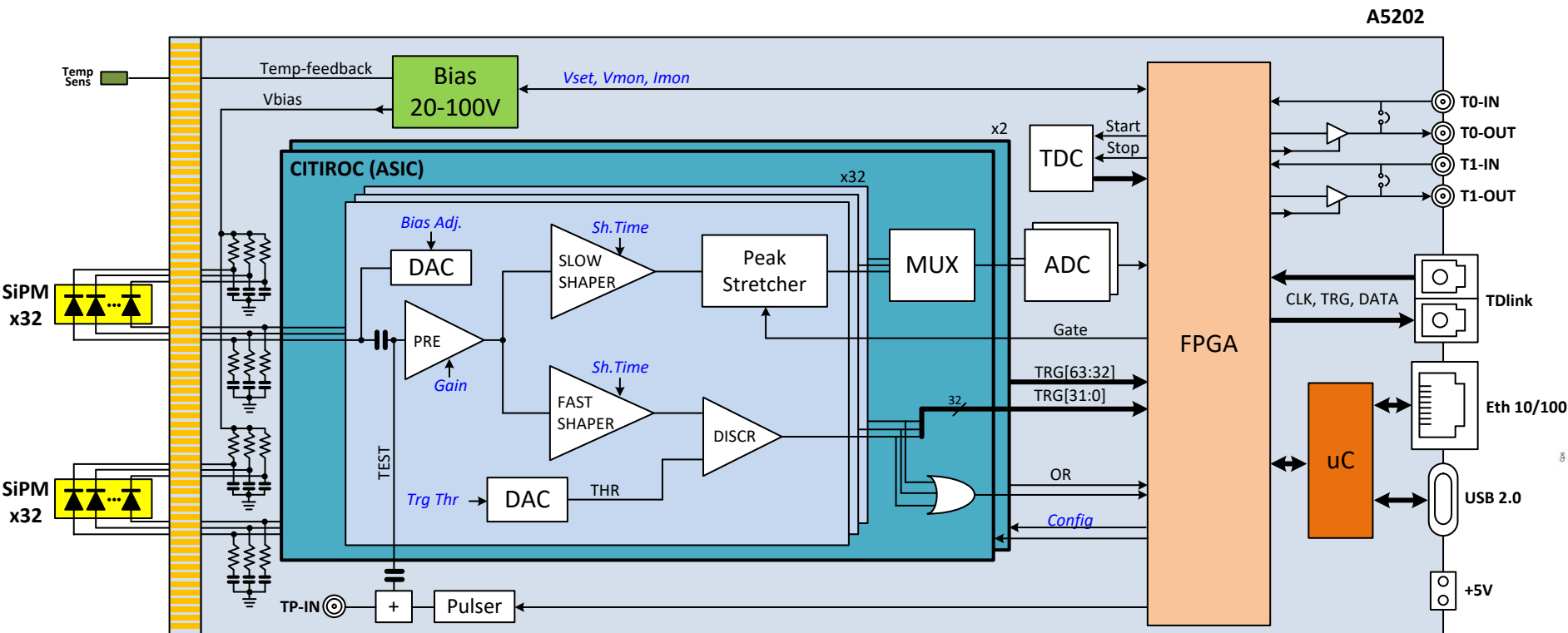
COMMON INFRASTRUCTURE

- **FERS:** Front End ASIC + ADC/TDC + Scalable Readout Infrastructure
- Easy integration of new ASICs
- **Scalability:** from single stand alone version for evaluation, to 10k/100k channels with same electronics
- **TDL:** daisy chainable optical link protocol with **data+sync**
- **Readout Tree:**
1 link = 16 FERS units
1 Concentrator = 8 links = 128 FERS = 8k/16k channels
Multiple Concentrators for unlimited readout...

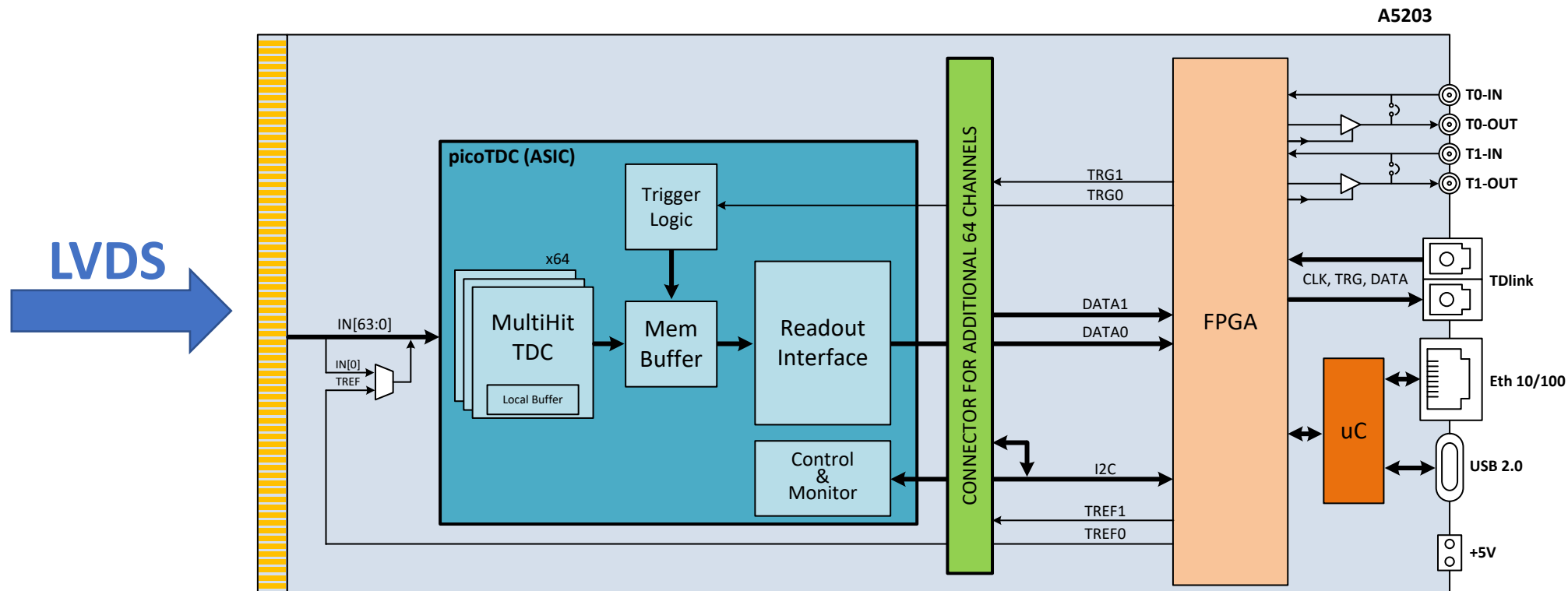


FERS A5202: 64 ch SiPM readout

- Based on **Citiroc** ASIC (Weeroc)
- Preamp, Fast shaper + Discrim, Slow shaper + Peak Sensing + Mux ADC
- Programmable gain (up to 600) and shaping time (up to 82.5 ns)
- High Voltage (up to 80 V) for SiPM biasing, with individual adjust
- Acq modes: spectroscopy (PHA), photon counting, timing list mode (ToA + ToT)
- Single photon detection (threshold at 1/3 p.e.)
- Timing resolution = ~ 0.3 ns RMS



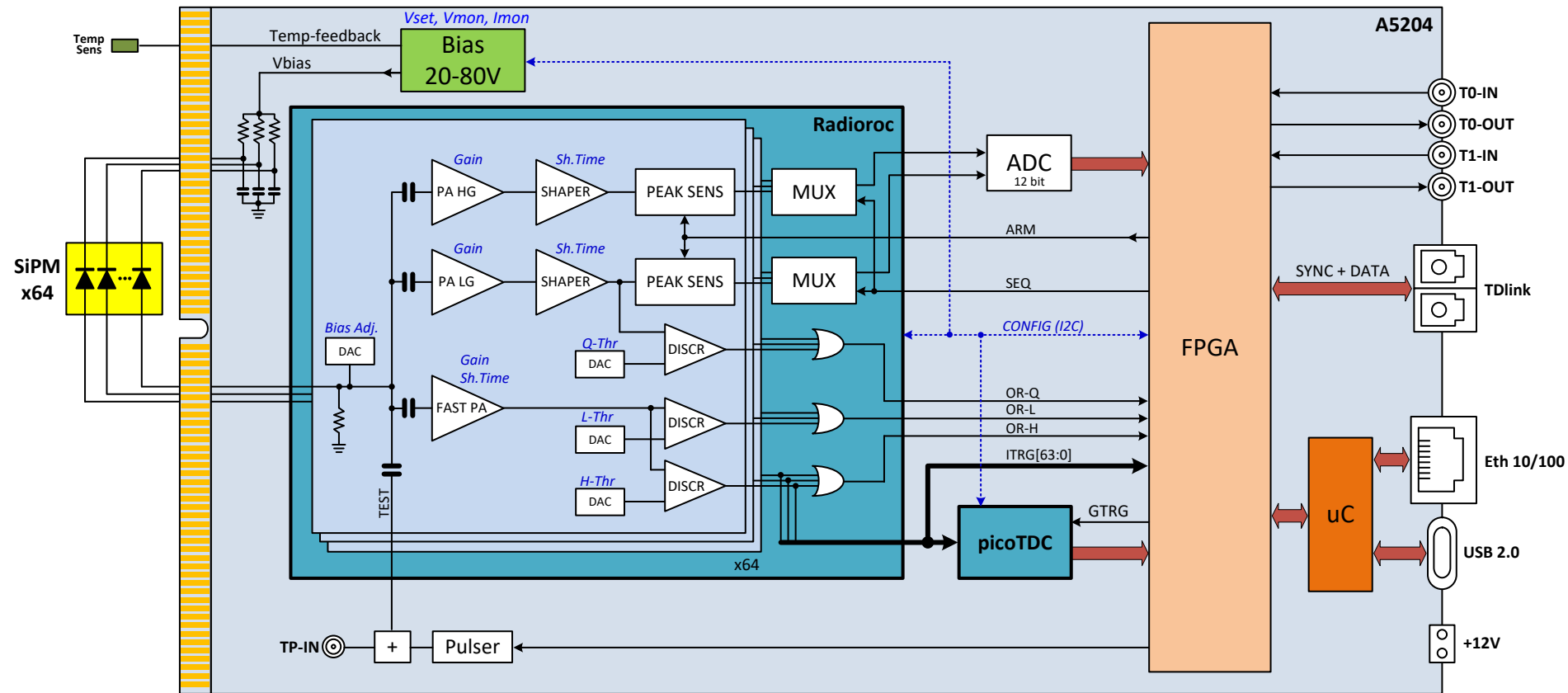
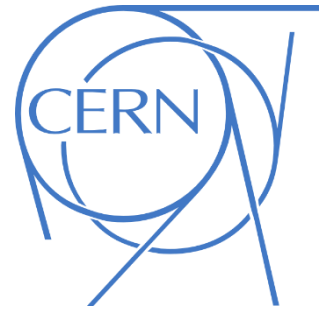
- Based on **picoTDC** ASIC (CERN)
- Start-Stop timing resolution = ~ 5 ps RMS (tested with pulser, 0.8 ns rising edge, 1 Vpp)
- Acq. modes: Common Start, Common Stop, Trg. Matching, Streaming
- Leading/Trailing edge or Leading + ToT
- Extension board (A5256) with fast discriminators (16+1 channels)



- Based on Radioroc (Weeroc) and picoTDC (CERN)
- Acq modes: spectroscopy (PHA), photon counting, timing list mode (ToA + ToT)
- Improved timing resolution: 55 ps FWHM on a single p.e.
- Counting rate up to 200 Mcps
- Gain up to 80, Shaping Time up to 1.2 μ s



weeroc



- Based on **Psiroc** (Weeroc) and **picoTDC** (CERN)
 - Same PCB of A5204
 - Best suited for Silicon Strip Detectors (SSD), GEM, PIN Diodes
 - Gain: from 0.125 mV/fC up to 4 mV/fC
 - Shaping time from 20 ns to 3 μ s
 - Min trigger threshold = 0,5 fC
 - Accepts both Positive and Negative inputs
 - Dynamic range up to 5 pC with PHA or 100 pC with ToT
 - Timing res = 150 ps RMS @ $Q_{IN}=4$ fC
-
- **Linearized ToT allows for high-resolution energy and ps timing, even at high rate and independent channels!**



weeroc



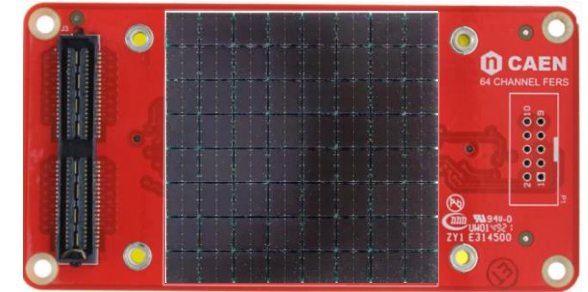
A5250: 2.54 mm Headers



A5260: remotization cable



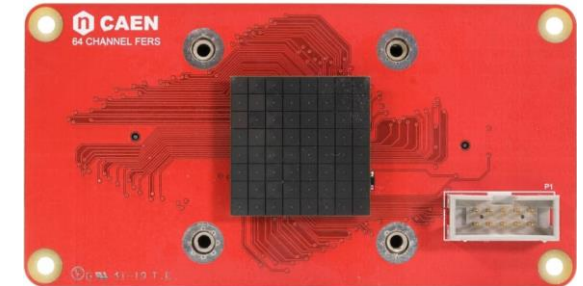
A5254: OnSemi Array-J Adapter



A5253: sparse SiPM cabling

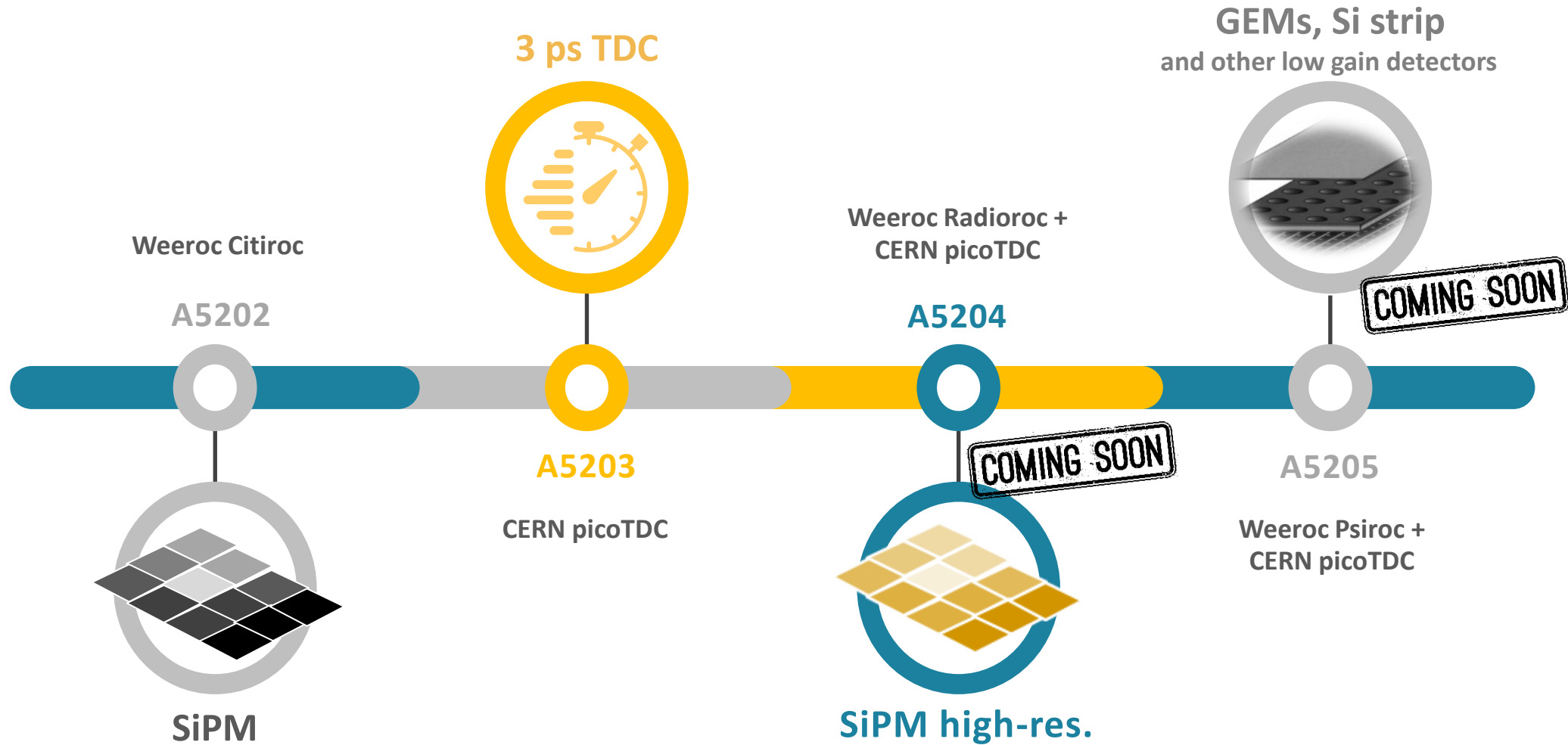


A5251: Hamamatsu MPPC Adapter



A5256: 16+1 Fast Discriminators





- Developed at CEA/LAL (Paris)
- Best suited for SiPM, Diamond, MCP, APD
- Switched Capacitor Array (64 samples)
- Up to 10 GS/s sampling rate
- Embedded ADC, $\sim 1 \mu\text{s}$ Conversion Time
- Ping-pong for low dead-time
- Independent channel readout
- Energy by waveform readout or ToT
- 16/32/64 channel eval board available

SAMPIC	
CHANNELS	16
SCA DEPTH	64 cells
SAMPLING RATE	3-8.4 (10.2 for 8 ch) GS/s
BANDWIDTH	1.6 GHz
DYNAMIC RANGE	1 V
ADC RESOLUTION	8-11 bit
CONVERSION TIME	0.2 μs @ 8 bit 1.6 μs @ 11 bit
READOUT TIME	25 + (6.2/sample) ns
SCA NOISE	1.3 mV RMS
TIME RESOLUTION	< 5 ps RMS
POWER CONSUMPTION	180 mW (1.8 V supply)



- Switched Capacitor Array, up to 2 GS/s
- CAEN-Tech is NALU representative in U.S.



	ASOC V3	AARDVARC V3	AODS V1	HDSOC V1
CHANNELS	4	4-8	1-4	32/64
SCA DEPTH	16K	32K	16K	2K
BANDWIDTH	0.8 GHz	2 GHz	0.5 GHz	1 GHz
TIMING RESOLUTION	35 ps	4-8 ps	<100 ps	<100 ps
SAMPLING RATE	2.4-3.6 GS/s	10-14 GS/s	1-2 GS/s	1-2 GS/s
APPLICATIONS	General Purpose ToF measurement	Accurate timing measurement	High Dynamic range Sparse detectors	High Density SiPM readout
FEATURES	Low cost	High Performance High timing resolution	Variable gain stages Flexible serial interface	Internally configurable triggering schemes

VMM3

DRS4

SAMPA

TEMPOROC

LIROC

GET

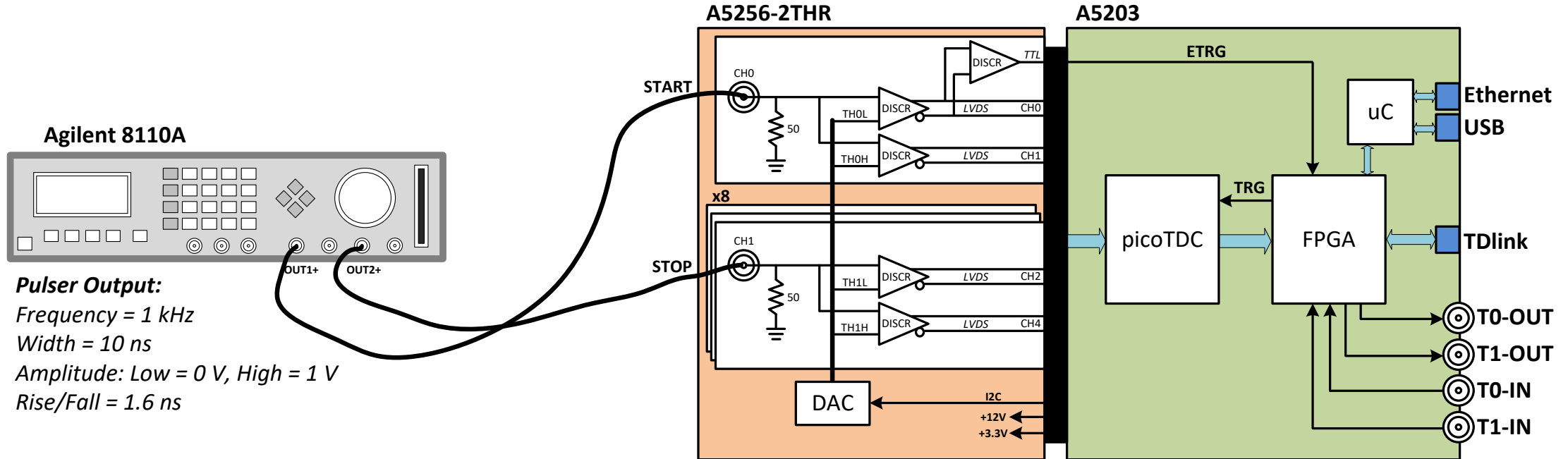


Setup:

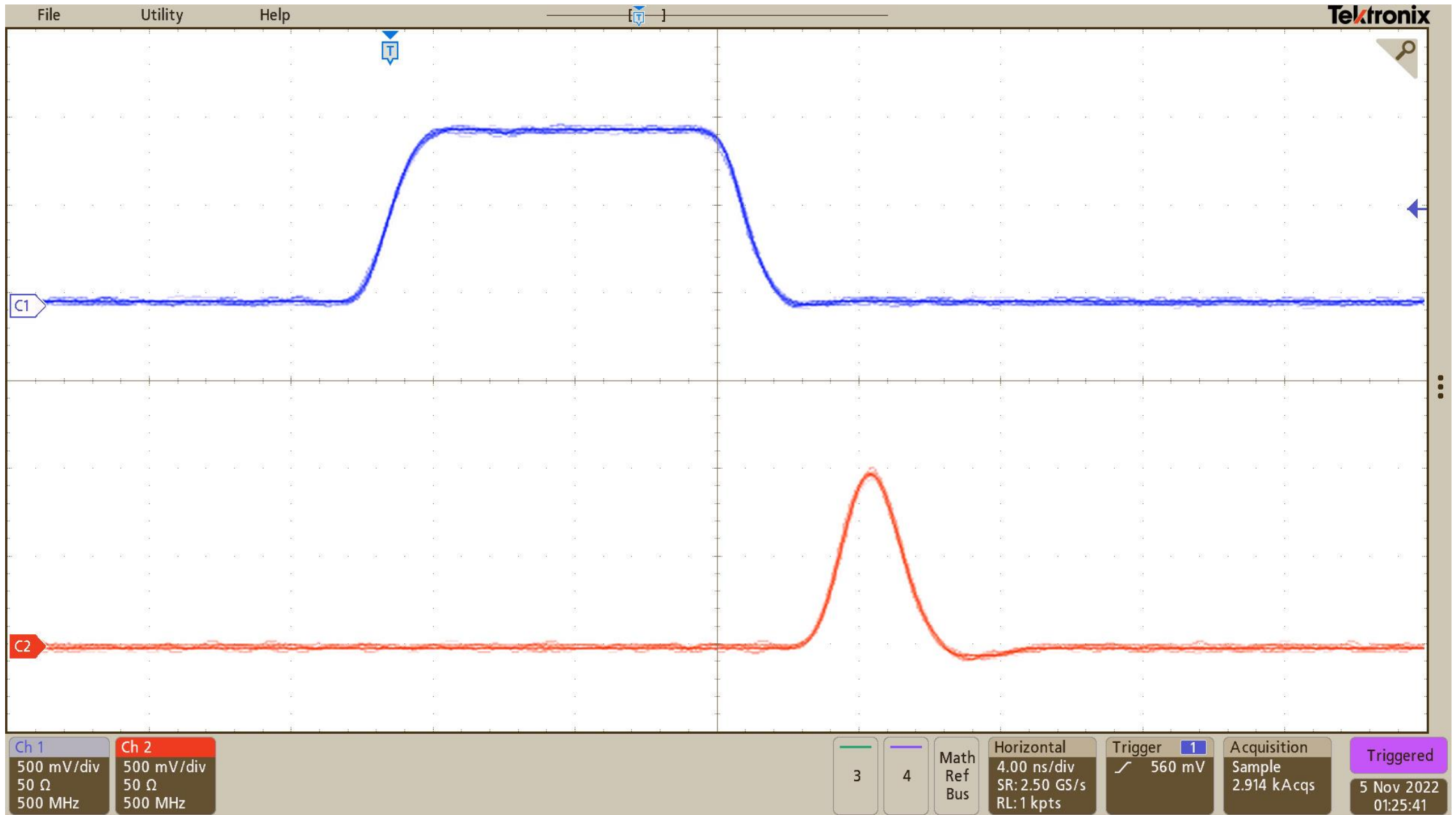
A5203: 64 ch. picoTDC

A5256: 8+1 ch. Dual Threshold Fast Discriminator

A8110A: Dual Pulse Generator

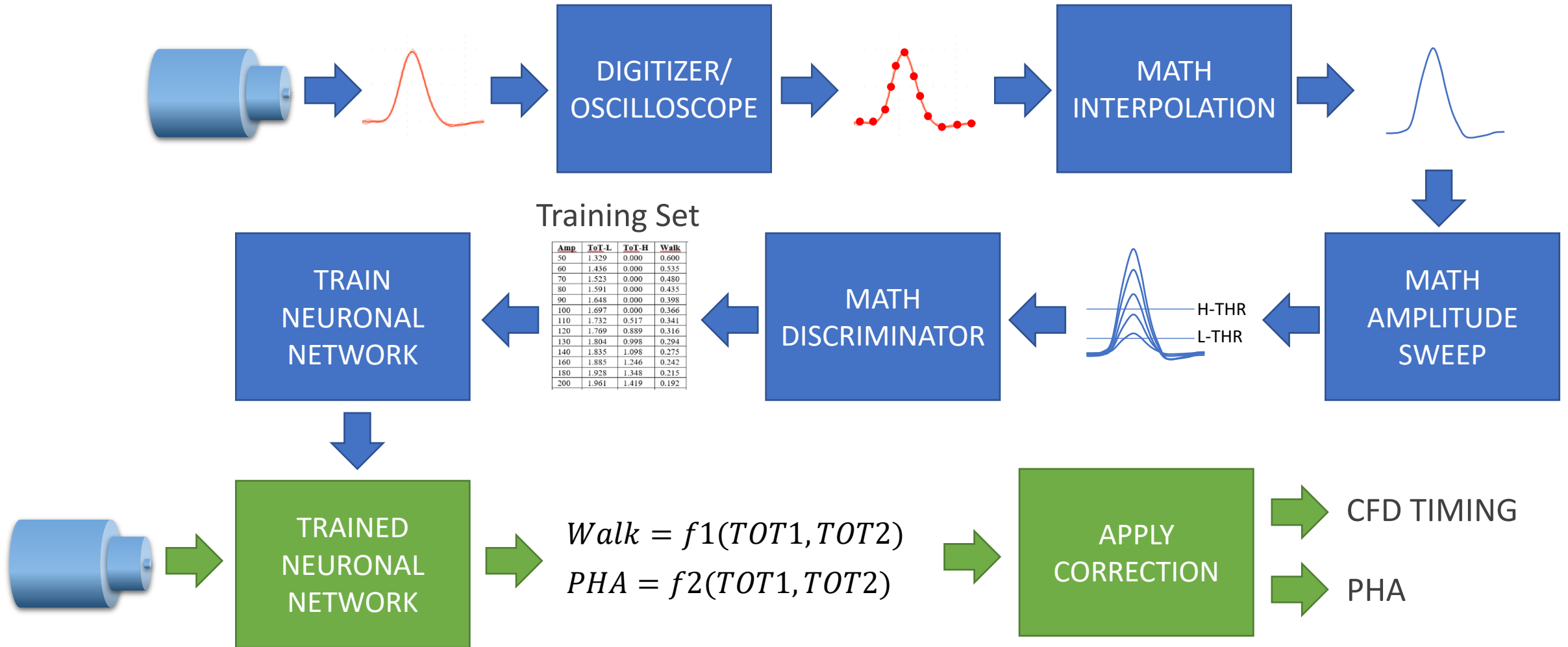


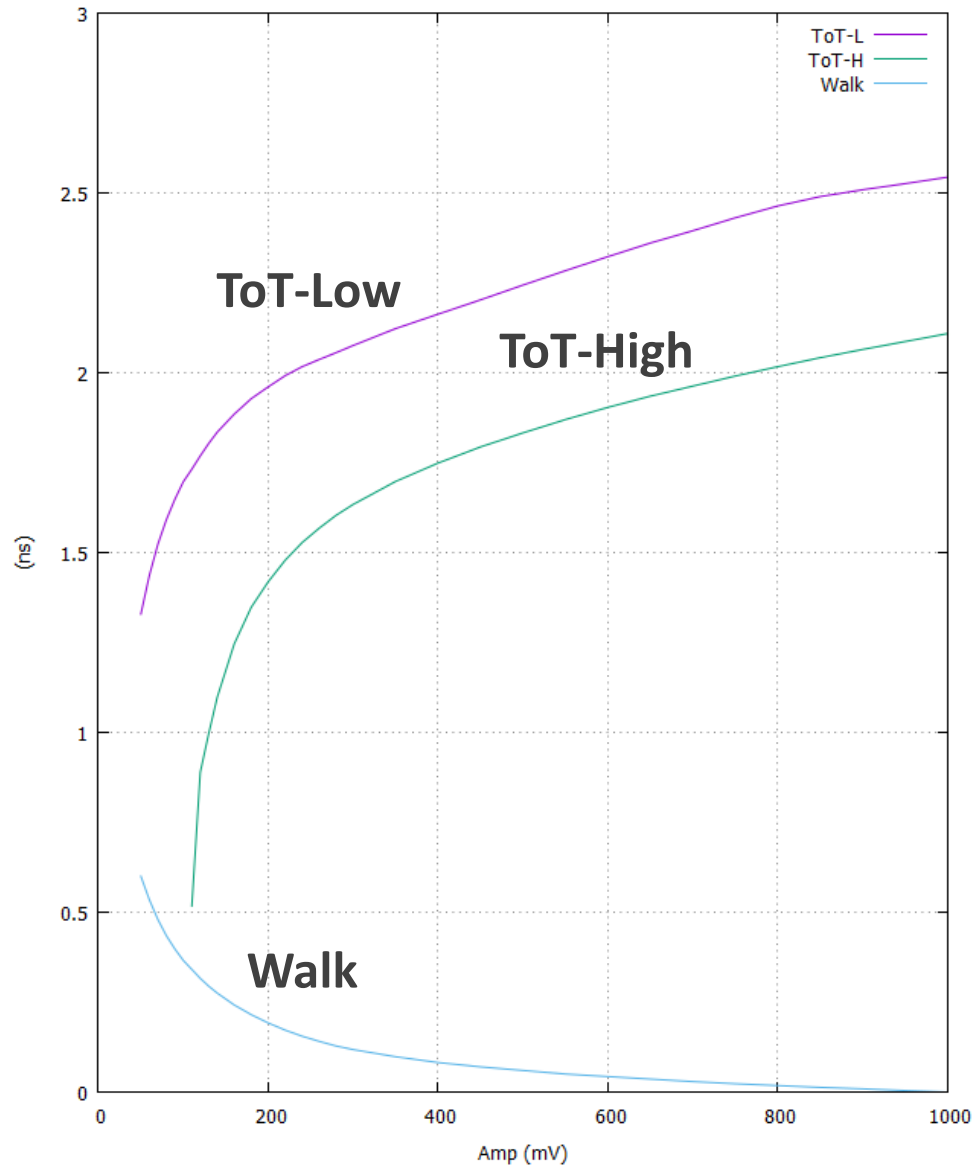
	Low Thr		High Thr	
	Mean	RMS	Mean	RMS
deltaT (start-stop)	4.7 ns	5 ps	4.9 ns	6 ps
ToT	10.6 ns	6.5 ps	10.2 ns	5.5 ps



ToT for Walk correction (CFD) and PHA

Need to find an algorithm that estimates Walk (for CFD timing) and Amplitude (for PHA) from the ToT.
Two thresholds (dual ToT) improve resolution at the cost of doubled channels





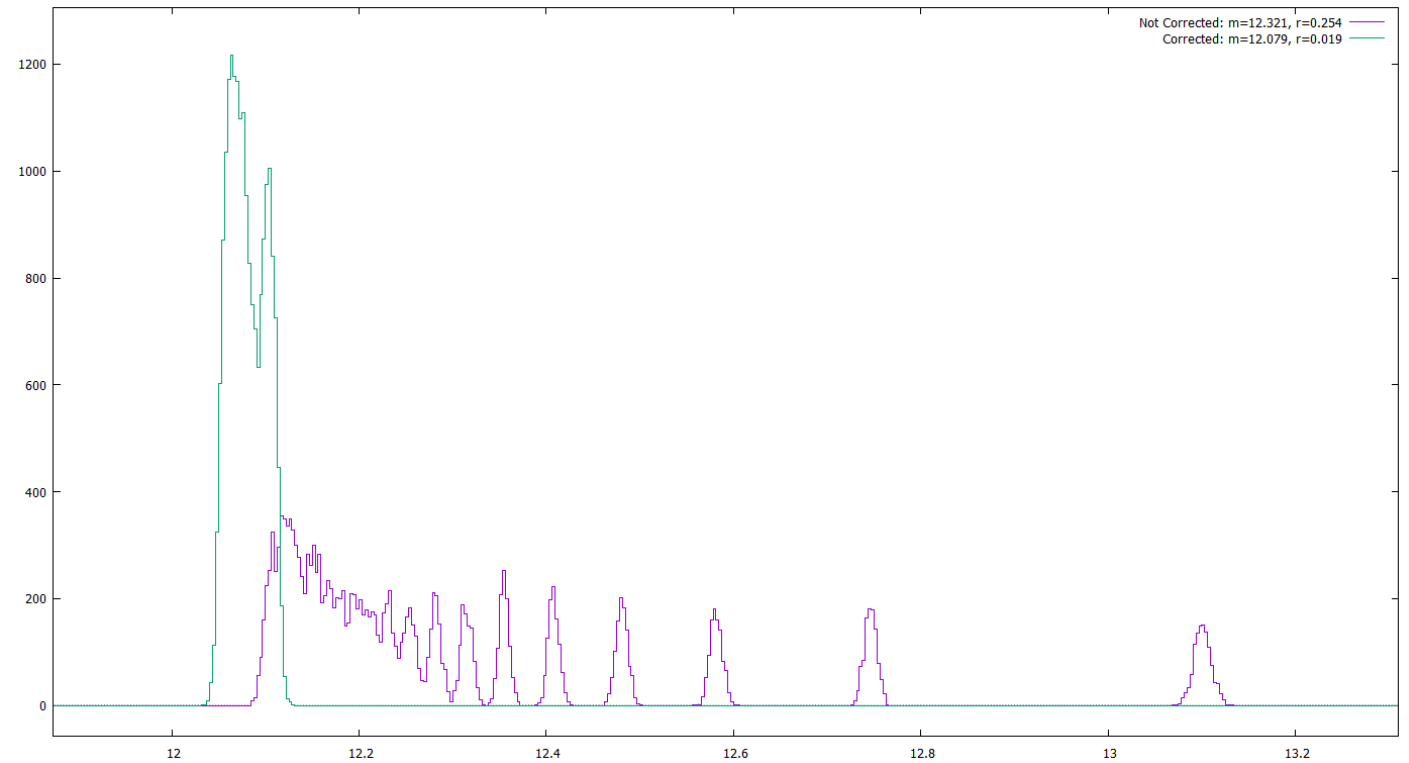
Amplitude Sweep from 50 mV to 1V:

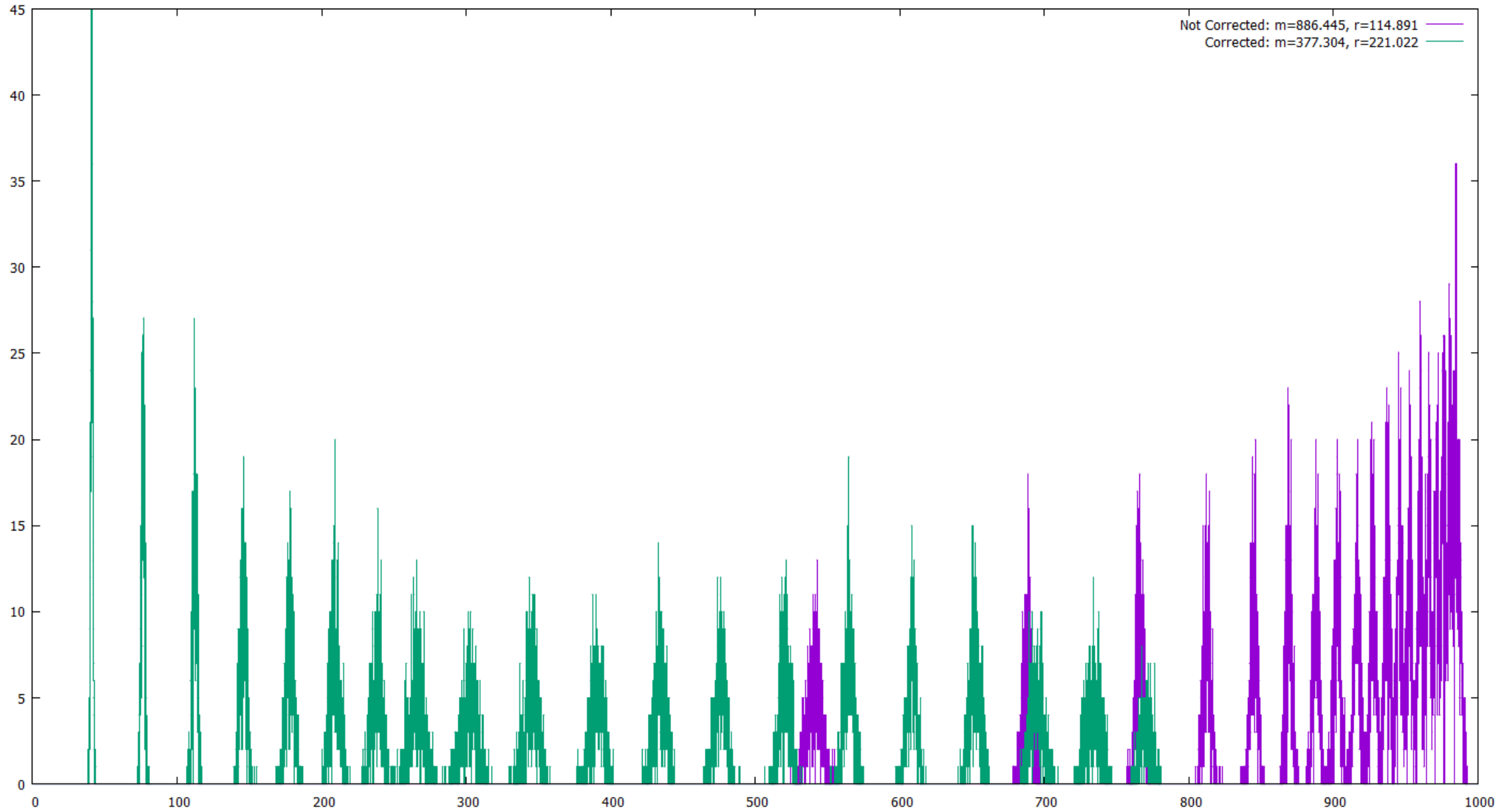
Low Thr. = 30 mV, High Thr. = 300 mV

$\Delta T = 254$ ps RMS (no correction)

Use sampled waveform to calculate Walk from ToT

$\Delta T = 19$ ps RMS (after correction)





VX2740/45:

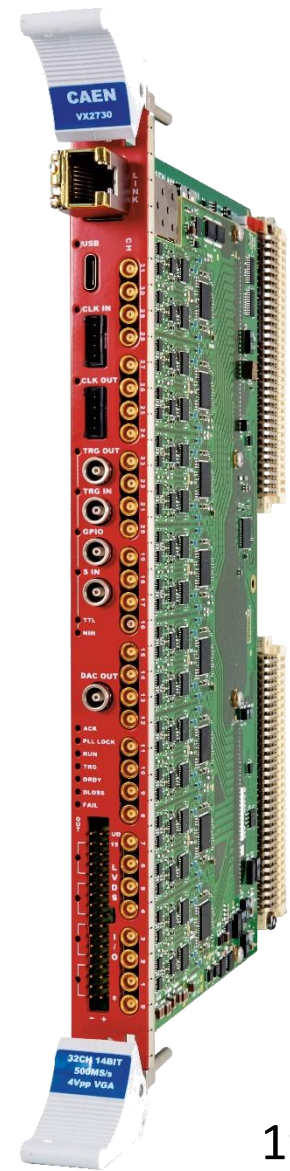
64 ch, 125 MS/s, 16 bit

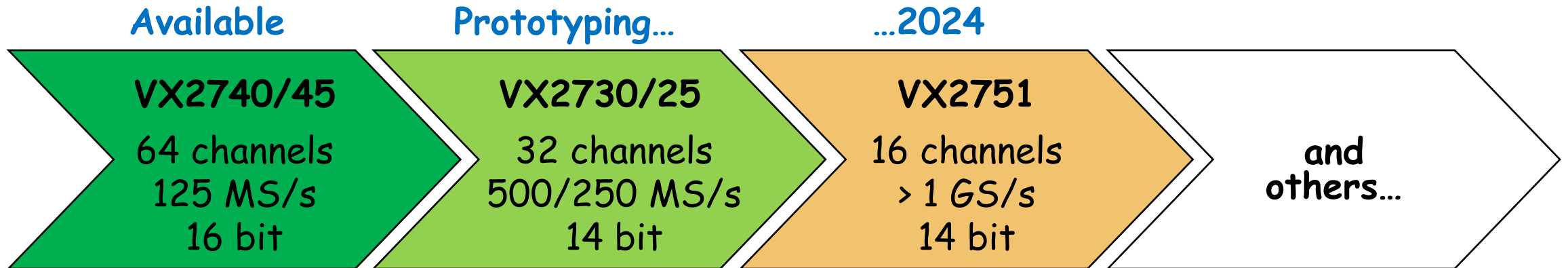
VX2730:

32 ch, 500 MS/s, 14 bit



- Form factors: VME64X, VME64 and Desktop
- **Inputs and Dynamic Range:**
 - V2740 → 2 V, DIFF or SE
 - V2745 → 40 mV ÷ 4 V (Gain: 0 to 40 dB, 0.5 dB steps), DIFF or SE
 - V2730 → 200 mV ÷ 4 V (Gain: 0 to 26 dB, 1 dB steps, t.b.d.), SE only
- **DC level** adjust (calibrated 16 bit DACs, channel by channel)
- **Readout** interfaces: 1/10 GbE, USB 3.1, Optical Link (up to ~ 300 MB/s)
- **DPP** functionalities: PHA, QDC, PSD, CFD, Zero Suppression
- **Open FPGA** to provide flexibility in the pulse processing algorithm
- Embedded Linux **ARM**



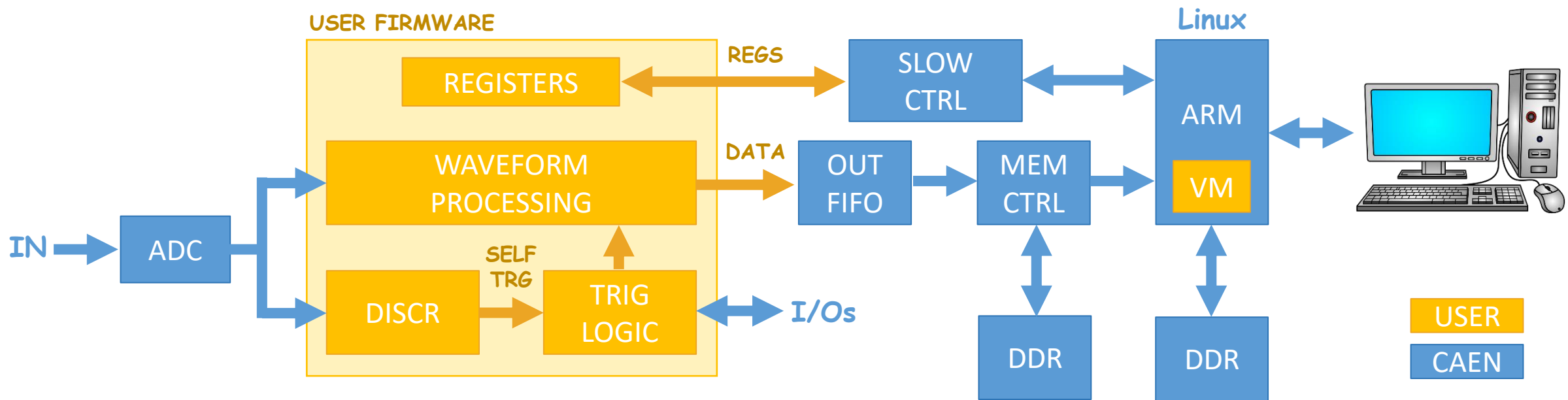


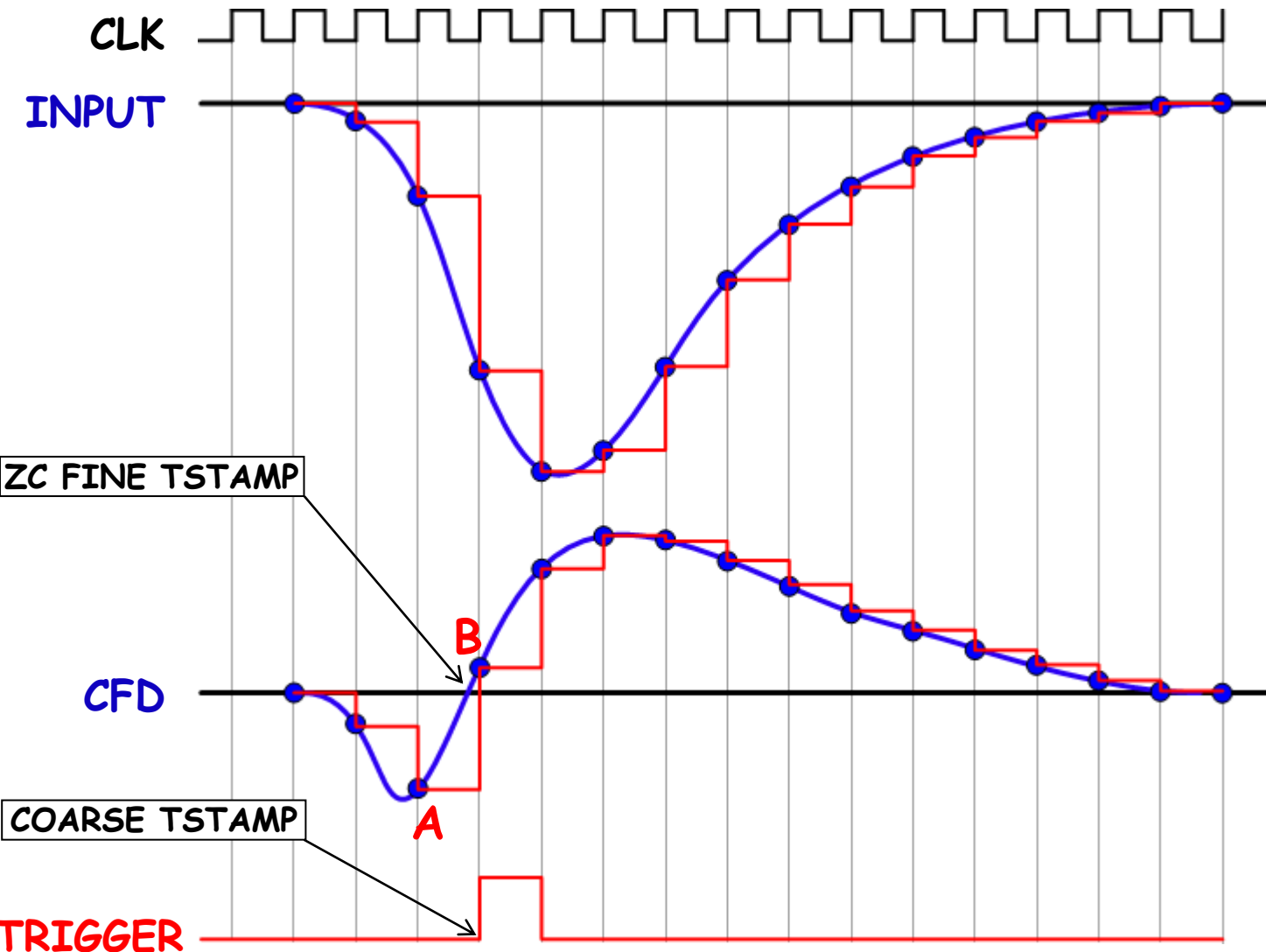
We provide infrastructure: ADC data flow, data buffering and transfer, slow control

You implement your algorithms for data processing, parameter extraction and trigger logic

Sci-Compiler: graphical FPGA programming tool with precompiled modules (logic, filters, ...)

FDK: FW development kit with VHDL templates, simulation models, signal inspection, etc.





digital CFD: same principle as analog

$$CFD_{N+1} = f * S_N - S_{N-D}$$

f = Fraction, D = delay

COARSE TSTAMP = $T_{CLK} * \text{Clock Counter}$

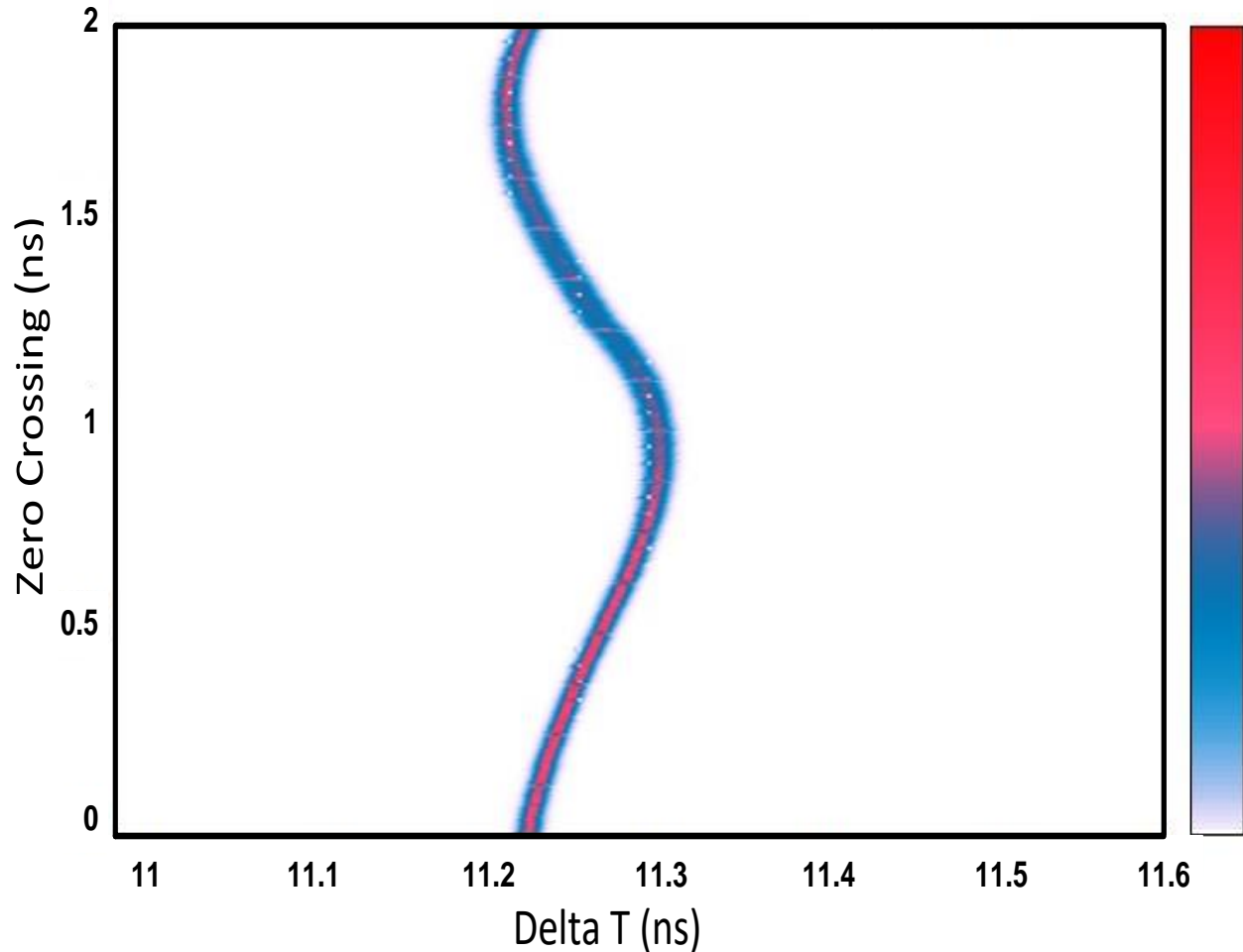
FINE TSTAMP = Interpolation between A and B

Linear Interpol.: $ZC = T_{CLK} * B/(B-A)$

Need 3/5 points on the rising edge to keep the interpolation error low => 5 GS/s for pulses with rising edge = 1ns

Curve fit (e.g. cubic): too complex for on-line FPGA calculation => need waveform readout

ZC correction LUT: increase timing resolution of the linear interpolation. Need algorithm training with real data.



Test with V1730 (500 MS/s, 14 bit)

The linear interpolation between two samples provides the ZC fine time (0 to 2 ns)

Scatter plot: X = measured ΔT , Y = ZC fine time

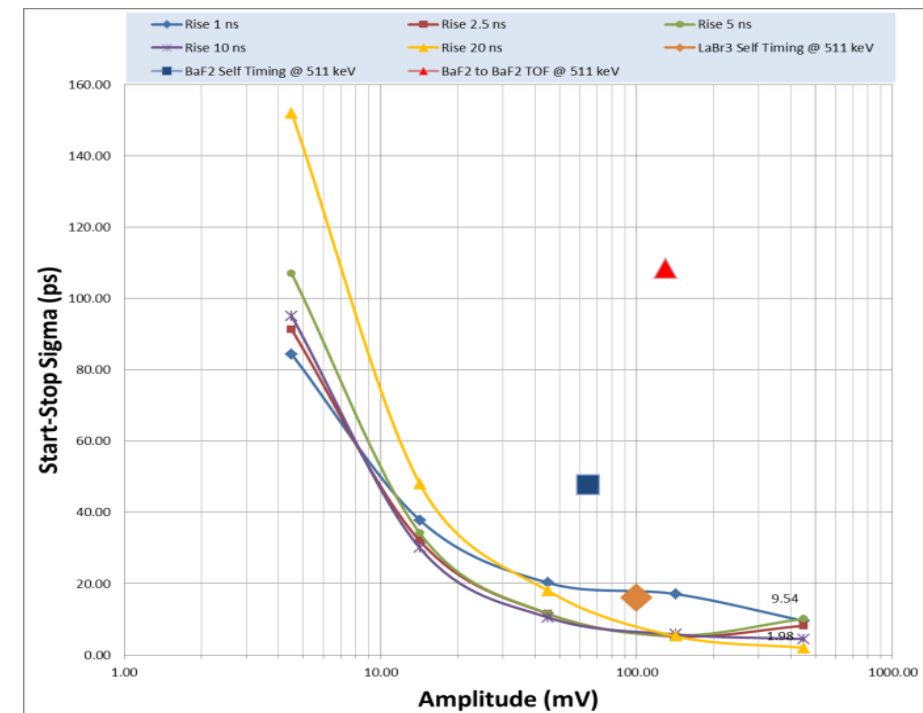
The interpolation error generates a predictable **pattern!**

A correction LUT can be created to compensate for the interpolation error

Need calibration run with real pulses to fill the LUT

Test Results with V1730: 500 MS/s, 14 bit digitizer

Test	Rise Time	Amplitude	ZC corr	Start-Stop Resolution	
				RMS	FWHM
Pulse Generator	1 ns	450 mV	✓	9.5 ps	22 ps
Pulse Generator	5 ns	450 mV	✓	10.1 ps	24 ps
Pulse Generator	20 ns	450 mV	✓	1.9 ps	4.5 ps
BaF ₂ to BaF ₂	1.3 ns	130 mV	✓	120 ps	280 ps
<i>BaF₂ to BaF₂</i>	<i>1.3 ns</i>	<i>130 mV</i>	✗	<i>538 ps</i>	<i>1.3 ns</i>
BaF ₂ to LaBr ₃	1.3/15 ns	130/200 mV	✓	186 ps	437 ps
Nal to Nal	20 ns	100 mV	✓	1.02 ns	2.40 ns



Single Detector Resolution				
Detector Type	Size	PMT	T _{RES} (FWHM)	Notes
BaF ₂	1"	H3378-51	200 ps	
LaBr ₃	2"	R6231	~ 400 ps	extrapolated from BaF ₂ to LaBr ₃ Timing
Nal (TI)	2"	ETL 9266	1.7 ns	

A close-up, slightly blurred photograph of a hand raised in the air. The hand is positioned in the center-right of the frame, with fingers spread. The person's arm is wearing a red, ribbed sleeve. The background is out of focus, showing other people in a classroom or meeting setting, with some light-colored walls and possibly a screen or board in the distance.

Thank you
for your
attention

Any question/curiosity?